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PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In Re U.S. Patent Application )

Applicant: Hiroaki Ueno )

Serial No. )

Filed: November 30, 2001 )

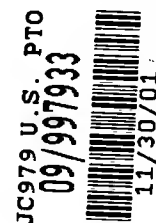
For: METHOD OF MEASURING )  
NON-LINEARITY IN )  
MAGNETIC RECORDING/ )  
REPRODUCTION, DEVICE )  
FOR MAGNETIC RECORDING/ )  
REPRODUCTION AND LST )  
FOR MAGNETIC RECORDING/ )  
REPRODUCTION )

Art Unit: )

*I hereby certify that this paper is being deposited with the United States Postal Service as EXPRESS MAIL in an envelope addressed to: U.S. Patent & Trademark Office, P.O. Box 2327, Arlington, VA 22202, on this date.*

11-30-01  
Date

David Owen  
Express Mail No. EL84622266US



INFORMATION DISCLOSURE STATEMENT

Assistant Commissioner for Patents  
Washington, D.C. 20231

Sir:

In accordance with 37 C.F.R. §§1.56, 1.97 and 1.98, Applicant through counsel herewith submits copies of the publications as set forth in the attached form PTO-1449 as follows:

OTHER DOCUMENTS

1. "A Generalized Frequency Domain Nonlinearity Measurement Method", Xiaodong Che, et al.; *IEEE Transactions on Magnetism*, Vol. 30, No. 6; November 1994.

2. "Non-Linear Interactions in a Series of Transitions", Alexander Taratorin et al.; *IEEE Transactions on Magnetism*, Vol. 33, No. 1; January 1997.

Applicant respectfully requests that the Examiner consider the above-listed references in the examination of this application and list these references of record in the application.

Respectfully submitted,

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November 30, 2001

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